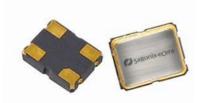


3.3V CMOS Low Jitter XO





3.2 x 2.5mm Ceramic SMD

Product Features

- 1 to 106.25 MHz Frequency Range
- <1 ps RMS jitter
- 3.3V CMOS compatible logic levels
- Designed for standard reflow and washing techniques
- Low power standby mode
- Pb-free and RoHS/Green compliant

Product Description

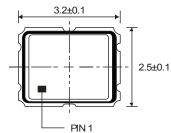
The FK Series 3.3V crystal clock oscillator achieves superb stability and low power consumption over a broad range of operating conditions and frequencies. The low jitter output clock signal, generated internally with a non-PLL oscillator design, is compatible with LVCMOS logic levels. The device, available on tape and reel, is contained in a 3.2 x 2.5mm surface-mount ceramic package.

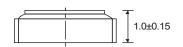
Applications

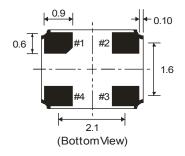
Ideal for compact, high-density applications requiring low power or tight stability, including:

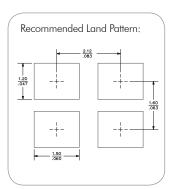
- Network adapter cards
- Portable Multimedia Devices
- Hard Disk Drives
- GPS/Navigation
- Bluetooth
- 802.11a/b/g WiFi

Package:





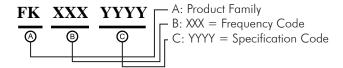




Pin Functions:

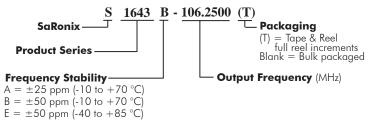
Pin	Function
1	OE Function
2	Ground
3	Clock Output
4	V_{DD}

Part Ordering Information:



Following the above format, Saronix-eCera part numbers will be assigned upon confirmation of exact customer requirements.

Legacy Ordering Information - For Reference Only:



SaRonix-eCera™ is a Pericom® Semiconductor company • US: +1-408-435-0800 TW: +886-3-4518888

• www.saronix-ecera.com

3.3V CMOS Low Jitter XO FK





FK Series Crystal Clock Oscillator (XO) Legacy \$1643 Series | 3.2 x 2.5mm

Electrical Performance

	Parameter	Min.	Тур.	Max.	Units	Notes	
Output Frequen	cy	1		106.25	MHz	As specified	
Supply Voltage		2.97	3.3	3.63	V		
Carol Caront O to t Facility				10	A	1 to 50 MHz	
Supply Current	Supply Current, Output Enabled			18	mA	50 to 106.25 MHz	
Supply Current	, Standby Mode			10	μΑ	Output Hi-Z	
Frequency Stab	ility			±20 to ±50	ppm	See Note 1 below	
On anating Tame	O (T) P			+70	°C	Commercial (standard)	
Operating Temperature Range		-40		+85		Industrial (standard)	
Output Logic 0,	$V_{ m OL}$			10% V _{DD}	V		
Output Logic 1,	V _{OH}	90% V _{DD}			V		
Output Load				15	pF		
Duty Cycle		45		55	%	Measured 50% V _{DD}	
Rise and Fall Ti	me			5	ns	Measured 10/90% of waveform	
Jitter, Phase	1 to 106.25 MHz			1	ps RMS (1-σ)	10kHz to 20 MHz frequency band	
Jitter,	up to 75 MHz			5	DMC (1	20,000 - di	
Accumulated	cumulated 75 to 106.25 MHz	3	ps RMS (1-σ)	20.000 adjacent periods			
Jitter,	up to 75 MHz		50			100,000	
Total	75 to 106.25 MHz 30 ps рк-рк	ps pk-pk	100.000 random periods				

- Stability includes all combinations of operating temperature, load changes, rated input (supply) voltage changes, initial calibration tolerance (25°C), aging (1 year at 25°C average effective ambient temperature), shock and vibration.
- For specifications othere than those listed, please contact sales.

Output Enable / Disable Function

Parameter	Min.	Тур.	Max.	Units	Notes
Input Voltage (pin 1), Output Enable	0.7 V _{DD}			V	or open
Input Voltage (pin 1), Output Disable (low power standby)			0.3 V _{DD}	V	Output is Hi-Z
Internal Pullup Resistance	50			kΩ	
Output Disable Delay			100	ns	
Output Enable Delay			10	ms	

Absolute Maximum Ratings

Parameter	Min.	Тур.	Max.	Units	Notes
Storage Temperature	-55		+125	°C	

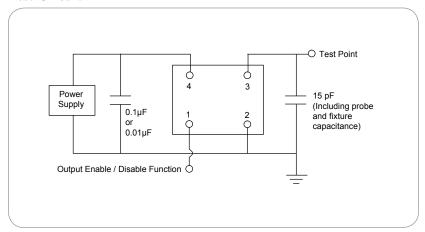




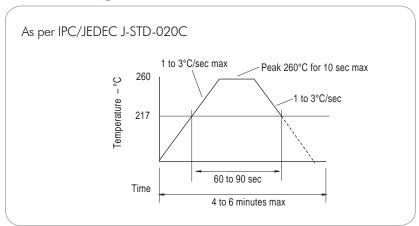


FK Series Crystal Clock Oscillator (XO) **Legacy S1643 Series | 3.2 x 2.5mm**

Test Circuit



Reflow Soldering Profile



Reliability Test Ratings

This product is rated to meet the following test conditions:

Туре	Parameter	Test Condition
Mechanical	Shock	MIL-STD-883, Method 2002, Condition B
Mechanical	Solderability	JESD22-B102-D Method 2 (Preconditioning E)
Mechanical	Terminal strength	MIL-STD-883, Method 2004, Condition D
Mechanical	Gross leak	MIL-STD-883, Method 1014, Condition C
Mechanical	Fine leak	MIL-STD-883, Method 1014, Condition A2 ($R_1 = 2x10^{-8}$ atm cc/s)
Mechanical	Solvent resistance	MIL-STD-202, Method 215
Environmental	Thermal shock	MIL-STD-883, Method 1011, Condition A
Environmental	Moisture resistance	MIL-STD-883, Method 1004
Environmental	Vibration	MIL-STD-883, Method 2007, Condition A
Environmental	Resistance to soldering heat	J-STD-020C Table 5-2 Pb-free devices (2 cycles max)

